

August 1986 Revised March 2000

DM74LS74A

Dual Positive-Edge-Triggered D Flip-Flops with Preset, Clear and Complementary Outputs

General Description

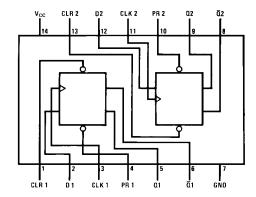
This device contains two independent positive-edge-triggered D flip-flops with complementary outputs. The information on the D input is accepted by the flip-flops on the positive going edge of the clock pulse. The triggering occurs at a voltage level and is not directly related to the transition time of the rising edge of the clock. The data on the D input may be changed while the clock is LOW or HIGH without affecting the outputs as long as the data setup and hold times are not violated. A low logic level on the preset or clear inputs will set or reset the outputs regardless of the logic levels of the other inputs.

Ordering Code:

Order Number	Package Number	Package Description
DM74LS74AM	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150 Narrow
DM74LS85ASJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
DM74LS74AN	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Connection Diagram



Function Table

Inputs				Out	puts
PR	CLR	CLK	D	Q	Q
L	Н	Х	Х	Н	L
Н	L	X	Х	L	Н
L	L	X	Х	H (Note 1)	H (Note 1)
Н	Н	1	Н	Н	L
Н	Н	1	L	L	Н
Н	Н	L	Х	Q_0	\overline{Q}_0

- H = HIGH Logic Level
- X = Either LOW or HIGH Logic Level
- L = LOW Logic Level
- ↑ = Positive-going Transition

 \mathbf{Q}_0 = The output logic level of Q before the indicated input conditions were established.

Note 1: This configuration is nonstable; that is, it will not persist when either the preset and/or clear inputs return to their inactive (HIGH) level.

Absolute Maximum Ratings(Note 2)

Supply Voltage 7V Input Voltage 7V Operating Free Air Temperature Range $0^{\circ}\text{C to } +70^{\circ}\text{C}$ Storage Temperature Range $-65^{\circ}\text{C to } +150^{\circ}\text{C}$

Note 2: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Recommended Operating Conditions

Symbol	Paramete	Min	Nom	Max	Units	
V _{CC}	Supply Voltage		4.75	5	5.25	V
V _{IH}	HIGH Level Input Voltage		2			V
V _{IL}	LOW Level Input Voltage				0.8	V
I _{ОН}	HIGH Level Output Currer	nt			-0.4	mA
I _{OL}	LOW Level Output Curren	t			8	mA
f _{CLK}	Clock Frequency (Note 3)		0		25	MHz
f _{CLK}	Clock Frequency (Note 4)		0		20	MHz
t _W	Pulse Width	Clock HIGH	18			
	(Note 3)	Preset LOW	15			ns
		Clear LOW	15			
t _W	Pulse Width	Clock HIGH	25			
	(Note 4)	Preset LOW	20			ns
		Clear LOW	20			
t _{SU}	Setup Time (Note 3)(Note 5)		20↑			ns
t _{SU}	Setup Time (Note 4)(Note 5)		25↑			ns
t _H	Hold Time (Note 5)(Note 6)		0↑			ns
T _A	Free Air Operating Temperature		0		70	°C

Note 3: $C_L = 15$ pF, $R_L = 2$ k Ω , $T_A = 25$ °C, and $V_{CC} = 5V$.

Note 4: $C_L=50$ pF, $R_L=2$ $k\Omega,\, T_A=25^{\circ}C,$ and $V_{CC}=5V.$

Note 5: The symbol ($\hat{}$) indicates the rising edge of the clock pulse is used for reference.

Note 6: $T_A = 25^{\circ}C$ and $V_{CC} = 5V$.

Electrical Characteristics

over recommended operating free air temperature range (unless otherwise noted)

Symbol	Parameter	Condition	s	Min	Typ (Note 7)	Max	Units
VI	Input Clamp Voltage	$V_{CC} = Min, I_I = -18 \text{ mA}$				-1.5	V
V _{OH}	HIGH Level	V _{CC} = Min, I _{OH} = Max		2.7	3.4		V
	Output Voltage	$V_{IL} = Max, V_{IH} = Min$		2.1	3.4		V
V _{OL}	LOW Level	V _{CC} = Min, I _{OL} = Max			0.35	0.5	
	Output Voltage	$V_{IL} = Max, V_{IH} = Min$			0.35	0.5	V
		I _{OL} = 4 mA, V _{CC} = Min			0.25	0.4	
II	Input Current @ Max	V _{CC} = Max	Data			0.1	
	Input Voltage	$V_I = 7V$	Clock			0.1	mA
			Preset			0.2	IIIA
			Clear			0.2	
I _{IH}	HIGH Level	V _{CC} = Max	Data			20	
	Input Current	$V_I = 2.7V$	Clock			20	
			Clear			40	μΑ
			Preset			40	
I _{IL}	LOW Level	V _{CC} = Max	Data			-0.4	
	Input Current	$V_I = 0.4V$	Clock			-0.4	mA
			Preset			-0.8	IIIA
			Clear			-0.8	
Ios	Short Circuit Output Current	V _{CC} = Max (Note 8)	,	-20		-100	mA
I _{CC}	Supply Current	V _{CC} = Max (Note 9)			4	8	mA

Note 7: All typicals are at $V_{CC} = 5V$, $T_A = 25^{\circ}C$.

Note 8: Not more than one output should be shorted at a time, and the duration should not exceed one second. For devices, with feedback from the outputs, where shorting the outputs to ground may cause the outputs to change logic state an equivalent test may be performed where V_O = 2.125V with the minimum and maximum limits reduced by one half from their stated values. This is very useful when using automatic test equipment.

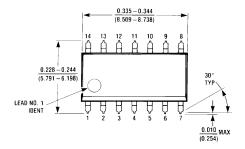
 $\textbf{Note 9:} \ \ \textbf{With all outputs OPEN, I}_{CC} \ \ \textbf{is measured with CLOCK grounded after setting the Q and } \ \overline{\textbf{Q}} \ \ \textbf{outputs HIGH in turn}.$

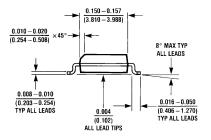
Switching Characteristics

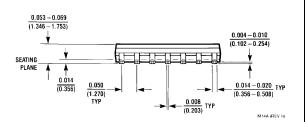
at $V_{CC} = 5V$ and $T_A = 25$ °C

		From (Input) To (Output)	$R_L = 2 k\Omega$				
Symbol	Parameter		C _L = 15 pF		C _L = 50 pF		Units
			Min	Max	Min	Max	
f _{MAX}	Maximum Clock Frequency		25		20		MHz
t _{PLH}	Propagation Delay Time LOW-to-HIGH Level Output	Clock to Q or Q		25		35	ns
t _{PHL}	Propagation Delay Time HIGH-to-LOW Level Output	Clock to Q or Q		30		35	ns
t _{PLH}	Propagation Delay Time LOW-to-HIGH Level Output	Preset to Q		25		35	ns
t _{PHL}	Propagation Delay Time HIGH-to-LOW Level Output	Preset to Q		30		35	ns
t _{PLH}	Propagation Delay Time LOW-to-HIGH Level Output	Clear to Q		25		35	ns
t _{PHL}	Propagation Delay Time HIGH-to-LOW Level Output	Clear to Q		30		35	ns

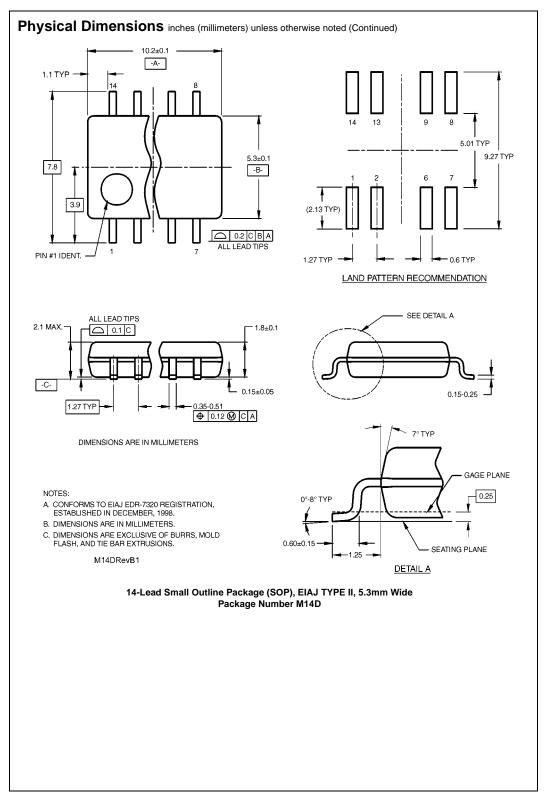
Physical Dimensions inches (millimeters) unless otherwise noted







14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150 Narrow Package Number M14A



Physical Dimensions inches (millimeters) unless otherwise noted (Continued) 0.740 - 0.770 (18.80 - 19.56)0.090 (2.286) 14 13 12 14 13 12 11 10 9 8 INDEX AREA 0.250 ± 0.010 (6.350 ± 0.254) PIN NO. 1 PIN NO. 1 IDENT 1 2 3 4 5 6 7 1 2 3 $\frac{0.092}{(2.337)}$ DIA 0.030 MAX (0.762) DEPTH OPTION 1 OPTION 02 $\frac{0.135 \pm 0.005}{(3.429 \pm 0.127)}$ 0.300 - 0.320 $\frac{0.630 - 8.128}{(7.620 - 8.128)}$ $\frac{0.145 - 0.200}{(3.683 - 5.080)}$ 0.060 4° TYP Optional (1.651) $\frac{0.008 - 0.016}{(0.203 - 0.406)}$ TYP 0.020 (0.508) 0.125 - 0.150 0.075 ± 0.015 $\overline{(3.175 - 3.810)}$ (1.905 ± 0.381) (7.112) MIN 0.014 - 0.0230.100 ± 0.010 (2.540 ± 0.254) (0.356 - 0.584) $\frac{0.050 \pm 0.010}{(1.270 - 0.254)}$ TYP 0.325 ^{+0.040} -0.015 8.255 + 1.016

14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N14A

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N144 (REV.F)